

P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
- 30	0.007 at V _{GS} = 10 V	- 18	31 nC			
	0.010 at V _{GS} = 4.5 V	- 15.7	31110			

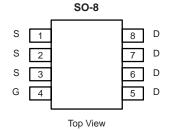
FEATURES

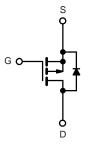
- DT-Trench Power MOSFET
- 100 % R_g Tested



APPLICATIONS

- · Load Switches
 - Notebook PCs
 - Desktop PCs





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	- 30	V	
Gate-Source Voltage		V_{GS}	± 20	v	
	T _C = 25 °C		- 18		
Continuous Prais Current (T = 150 °C)	T _C = 70 °C] , [- 15.7		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	- 14 ^{b, c}		
	T _A = 70 °C		- 11.6 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	- 60		
Continous Source-Drain Diode Current	T _C = 25 °C		- 5.3		
	T _A = 25 °C	- I _S	- 2.8 ^{b, c}		
Maximum Power Dissipation	T _C = 25 °C		5.9		
	T _C = 70 °C	1 5	3.9	10/	
	T _A = 25 °C	- P _D	2.7 ^{b, c}	W	
	T _A = 70 °C	1	1.8 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R_{thJA}	35	50	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	18	22]	

Notes

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under Steady State conditions is 85 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•	I.		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		- 20		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4.9			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	- 1.2		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μА	
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 15			Α	
		V _{GS} = - 10 V, I _D = - 13 A		0.007			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 10 A		0.010		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 13 A		40		S	
Dynamic ^b	L			ı	I.	1	
Input Capacitance	C _{iss}			2720		pF	
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		481			
Reverse Transfer Capacitance	C _{rss}	İ		395			
Total Oats Ohanna	Qg	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -13 \text{ A}$		53	80	nC	
Total Gate Charge				27	41		
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 13 A		8			
Gate-Drain Charge	Q _{gd}			13			
Gate Resistance	R_g	f = 1 MHz	0.4	2.1	4.2	Ω	
Turn-On Delay Time	t _{d(on)}			52	78	ns	
Rise Time	t _r	V_{DD} = - 15 V, R_{L} = 1.5 Ω		41	62		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		36	54		
Fall Time	t _f	İ		15	25		
Turn-On Delay Time	t _{d(on)}			12	20		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		9	15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		42	63		
Fall Time	t _f	İ		9	15		
Drain-Source Body Diode Characteristic	cs			•	I.	•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 18	Δ	
Pulse Diode Forward Current	I _{SM}				- 50	_ A	
Body Diode Voltage	V_{SD}	I _S = - 10 A, V _{GS} = 0 V		- 0.7	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			20	30	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	 10 A dl/dt = 100 A/us T = 25 °C		10	20	nC	
Reverse Recovery Fall Time	t _a	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		10		ne	
Reverse Recovery Rise Time	t _b			9		ns	

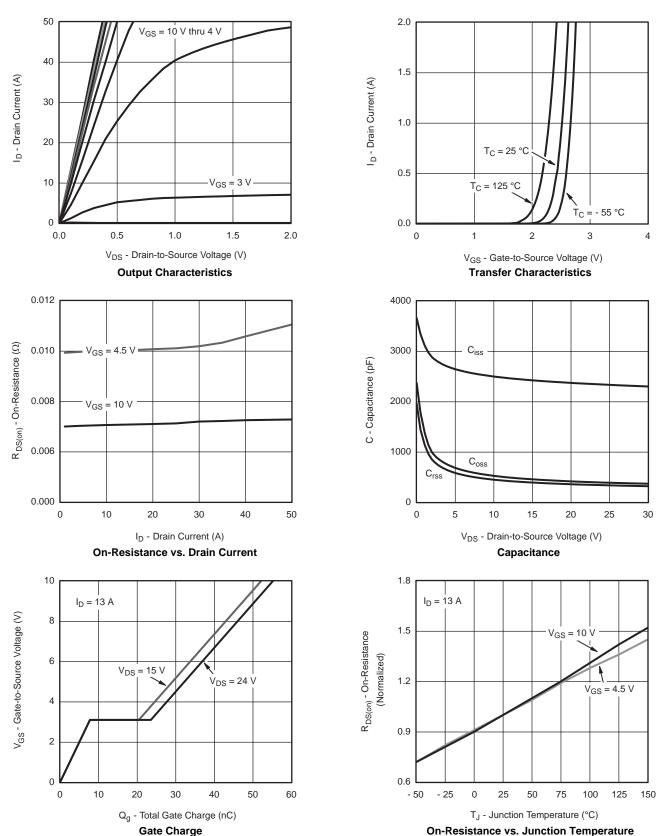
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

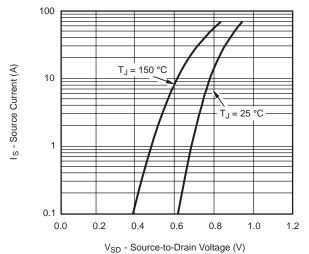


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

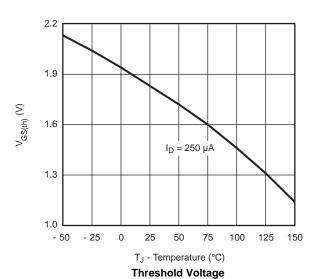




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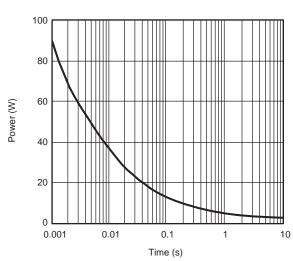


Source-Drain Diode Forward Voltage

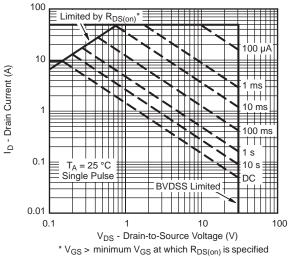


0.04 0.03 0.02 0.02 0.01 0.00 0 2 4 6 8 10

 $\label{eq:VGS} \mbox{V}_{GS} \mbox{ - Gate-to-Source Voltage (V)}$ On-Resistance vs. Gate-to-Source Voltage

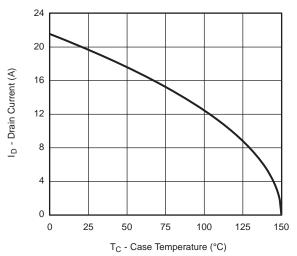


Single Pulse Power (Junction-to-Ambient)

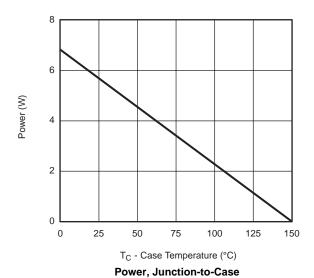


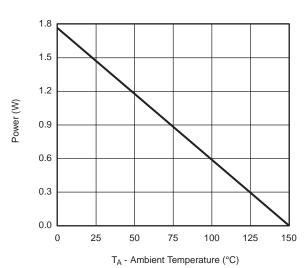
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*



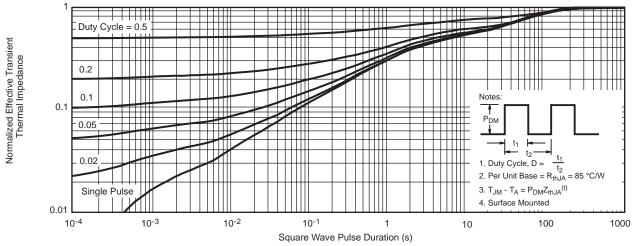


Power, Junction-to-Ambient

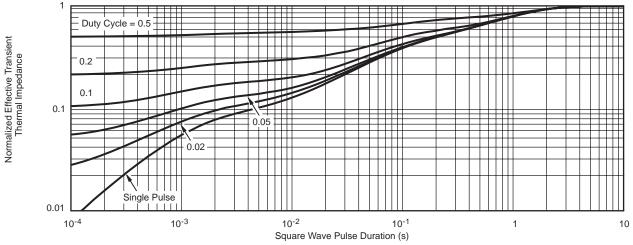
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot





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